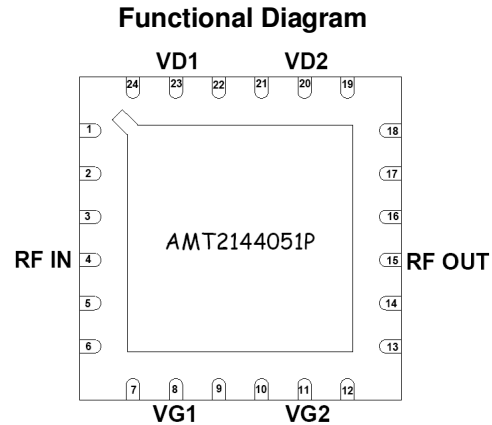


8.5 – 10.5 GHz 1 Watt Power Amplifier

Features

- ◆ Frequency Range : 8.5 – 10.5GHz
- ◆ 29.5 dBm output P1dB
- ◆ 16.5 dB Power gain
- ◆ 30% PAE
- ◆ High IP3
- ◆ Input Return Loss > 8.5 dB
- ◆ Output Return Loss > 12 dB
- ◆ Dual bias operation
- ◆ No external matching required
- ◆ DC decoupled input and output
- ◆ 0.5 μ m InGaAs pHEMT Technology
- ◆ Open cavity QFN Package



Typical Applications

- ◆ RADAR
- ◆ Military & space
- ◆ LMDS, VSAT

Description

The AMT2144051P is a X-band Power amplifier with 29.5dBm output P1dB. The PA uses two stages of amplification and operates in 8.5 – 10.5 GHz frequency range. The PA features 16.5 dB of gain with input and output return loss 8.5dB and 12 dB respectively. The PA has a high IP3 of 38dBm and 30% PAE. This feature enables it to be used in the applications requiring efficiency along with linearity. The chip operates with dual bias supply voltage. The die is fabricated using a reliable 0.5 μ m InGaAs pHEMT technology.

The package used is a SMD open cavity QFN Package with base metal made up of copper composite.

Absolute Maximum Ratings ⁽¹⁾

Parameter	Absolute Maximum	Units
Drain bias voltage (Vd)	+10	volts
Drain current (Id)	0.5	A
RF input power (RF _{in} at Vd=8V)	26	dBm
Operating temperature	-50 to +85	°C
Storage Temperature	-65 to +150	°C

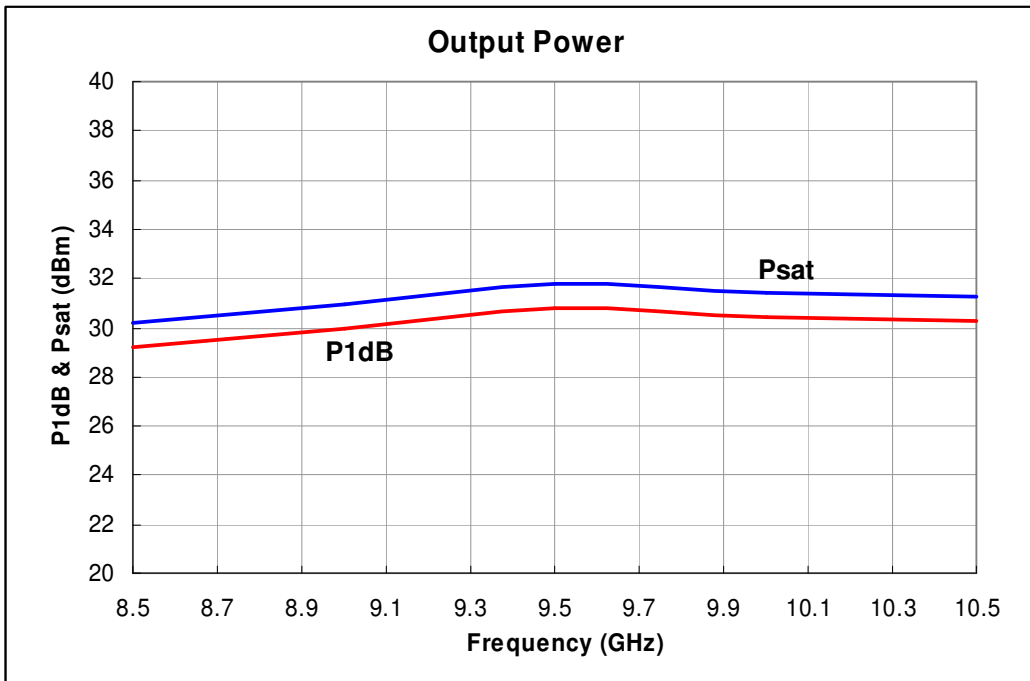
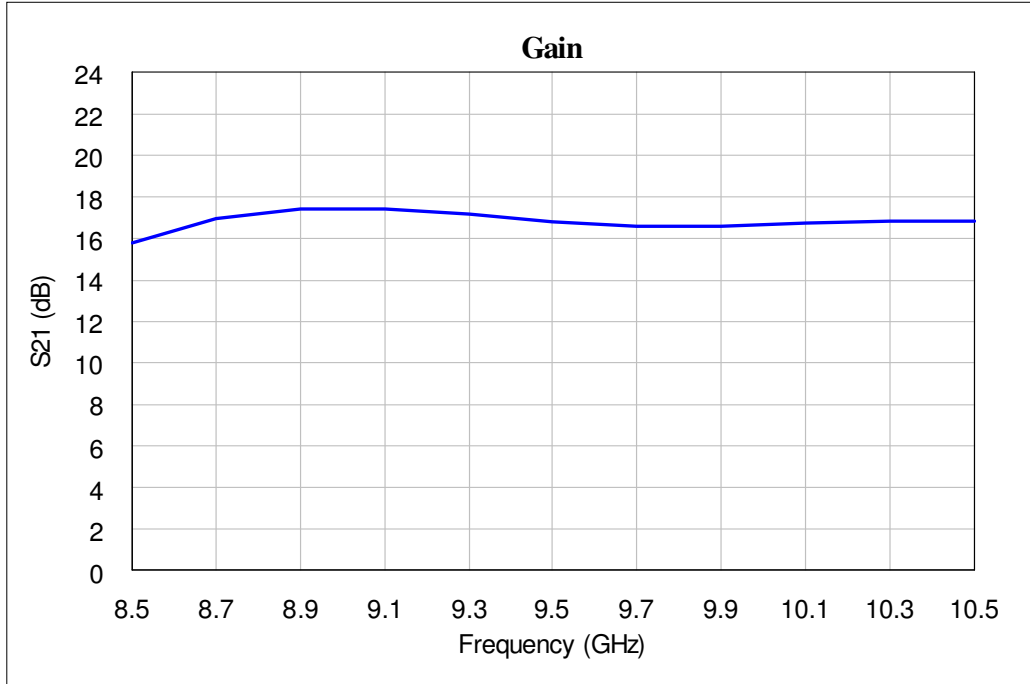
1. Operation beyond these limits may cause permanent damage to the component

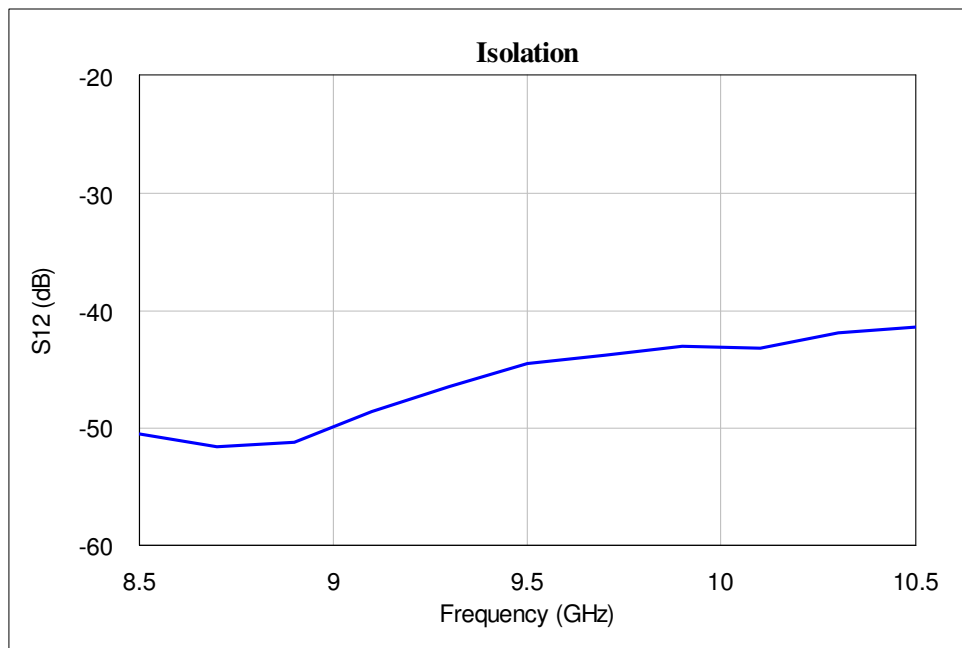
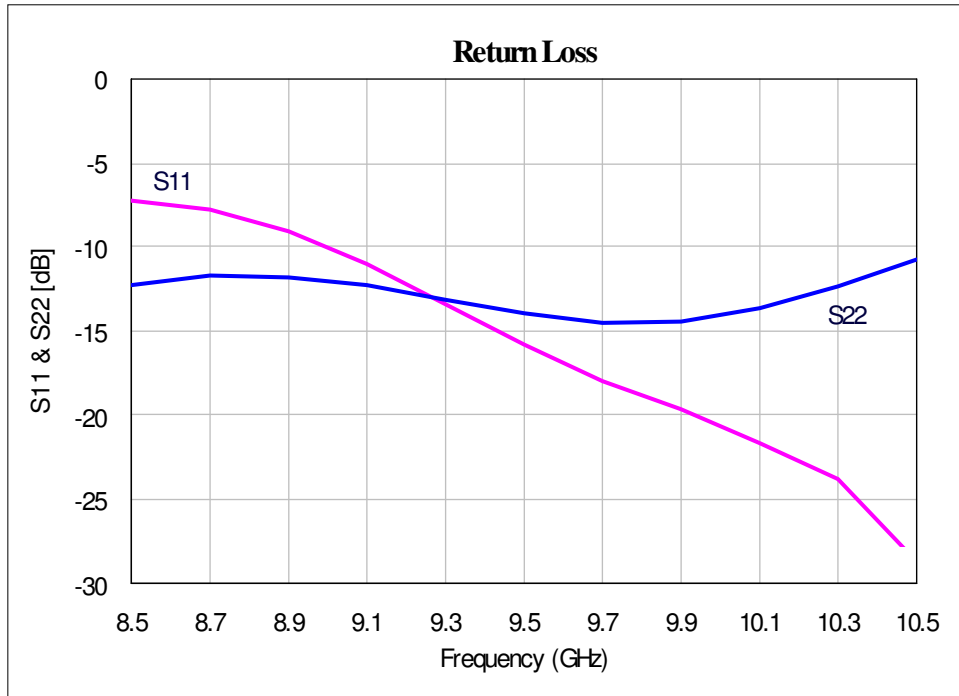
Electrical Specifications ⁽¹⁾ @ T_A = 25 °C, V_d = 8V, V_g = -1V, Z_o =50 Ω

Parameter	Typ.	Units
Frequency Range	8.5 – 10.5	GHz
Gain	16.5	dB
Gain Flatness	+/-0.5	dB
Output Power (P1 dB)	29.5	dBm
Input Return Loss	8.5	dB
Output Return Loss	12	dB
Saturated output power (P _{sat})	30.5	dBm
Output Third Order Intercept (IP3)	38	dBm
Power Added Efficiency (PAE)	30%	--
Supply Current (I _{dq})	370	mA
Supply Current (I _{dsat} ²)	520	mA

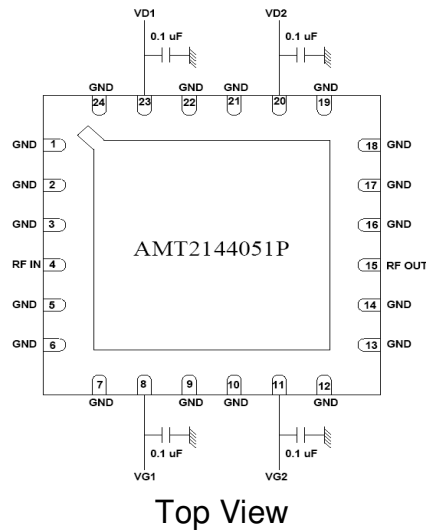
Note:

1. Electrical specifications as measured in test fixture.
2. I_{dsat} is the maximum current under input RF drive condition.

Test fixture data
 $V_d = 8V, V_g = -1V, \text{Total Current} = 370mA, T_A = 25^\circ C$


Test fixture data
 $V_d = 8V, V_g = -1V, \text{Total Current} = 370mA, T_A = 25^\circ C$


Pin details



Note:

- 1. Pad no. 4 : RF IN
- 2. Pad no. 8,11 : Vg1, Vg2
- 3. Pad no. 23,20 : Vd1, Vd2
- 4. Pad no. 15 : RF OUT

Recommended Assembly Diagram

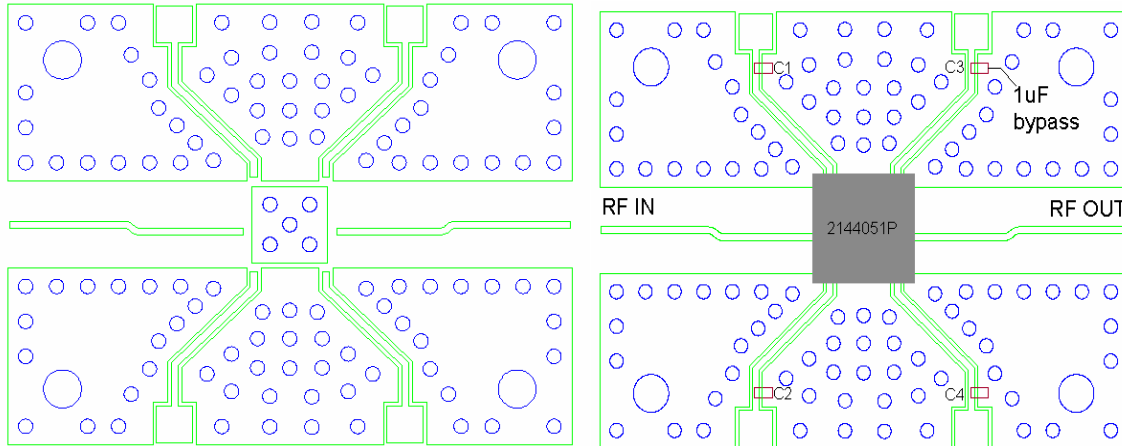


Fig: PCB Drawing

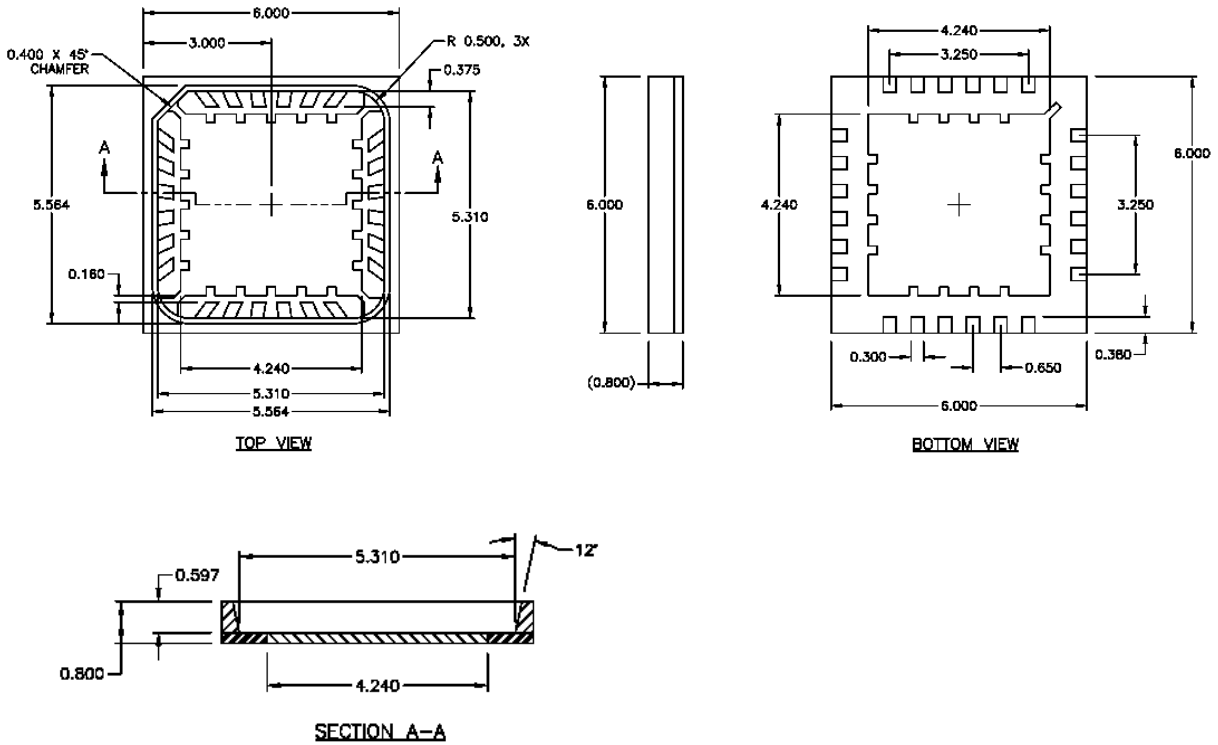
Fig: Package assembled on PCB

Note :

1. Input and output 50 ohm lines are on 5 mil RT Duroid substrate
2. 0.1 μ F and 1 μ F capacitors may be additionally used as a second level of bypass for reliable operation
3. The RF input & output ports are DC decoupled on-chip.
4. Proper heat sink like Aluminium or copper to be used for better reliability of package

Die attach: For Epoxy attachment, use of a two-component conductive epoxy is recommended. An epoxy fillet should be visible around the total die periphery. If Eutectic attachment is preferred, use of fluxless AuSn (80/20) 1-2 mil thick preform solder is recommended. Use of AuGe preform should be strictly avoided.

Wire bonding: For DC pad connections use either ball or wedge bonds. For best RF performance, use of 150 - 200 μ m length of wedge bonds is advised. Single Ball bonds of 250-300 μ m though acceptable, may cause a deviation in RF performance.

Package outline drawing


GaAs MMIC devices are susceptible to Electrostatic discharge. Proper precautions should be observed during handling, assembly & testing

All information and Specifications are subject to change without prior notice